

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination EMOTO, KEIJI	
		Examiner	Art Unit	Page 1 of 1
Paul L Rodriguez		2125		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2001/0017164 ✓	08-2001	Fukui et al.	138/125
	B	US-6,385,497 ✓	05-2002	Ogushi et al.	700/110
	C	US-6,246,204 ✓	06-2001	Ebihara et al.	318/649
	D	US-6,061,174 ✓	05-2000	Shiozawa et al.	359/361
	E	US-5,978,578 ✓	11-1999	Azarya et al.	717/100
	F	US-5,829,483 ✓	11-1998	Takahara et al.	138/109
	G	US-5,611,655 ✓	03-1997	Fukasawa et al.	414/217
	H	US-4,993,696 ✓	02-1991	Furukawa et al.	269/73
	I	US-4,906,496 ✓	03-1990	Hosono et al.	428/36.9
	J	US-4,475,223 ✓	10-1984	Taniguchi et al.	378/34
	K	US-4,368,219 ✓	01-1983	Nagata et al.	427/236
	L	US-3,743,760 ✓	07-1973	Sassin, Wolfgang	174/15.5
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.